# Selected Beam Studies at PITZ in 2017

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TEMF-DESY Collaboration Meeting 06.10.2017, TEMF, Darmstadt, Germany

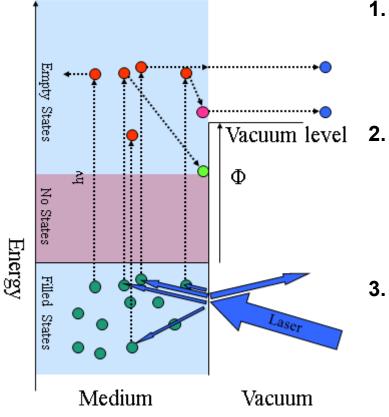
### Contents

- Photoemission modeling in the gun
- Updates on beam asymmetry studies
- > Summary & Discussion





## **Review of Three-Step Photoemission (PE) model**



#### For thorough descriptions, see:

#### . Optical excitation of electrons

- Reflection
- Transmission
- Energy distribution DOS

#### Migration of electrons to solid surface

- e<sup>-</sup>-phonon scattering (momentum change)
- e<sup>-</sup>-defect scattering (momentum change)
- e<sup>-</sup>-e<sup>-</sup> scattering (energy change, metal)
- Random Walk (Monte Carlo)

#### . Escape to vacuum

- Overcome work function
  - ✓ Eg(band gap) + Ea(electron affinity) for semiconductor
  - Eg variation, Ea variation
  - ✓ Surface potential reduction due to field effect

- W. E. Spicer, Phys. Rev., 112 114 (1958)
  M. Cardona and L.Ley: Photoemission in Solids 1, (Springer-Verlag, 1978)
  W. E. Spicer & A. Herrera-Gomez, SLAC-PUB-6306 (1993)
  D. H. Dowell et al., Appl. Phys. Lett., 63, 2035 (1993)
- J. Smedley, P3 workshop 2016
- K. L. Jensen, P3 workshop 2016
- L. Cultrera, EWPAA 2017
- J. Smedley, EWPAA 2017





## Motivation of further PE modeling at PITZ

- Explain PE associated measurement-simulation discrepancies in the gun
  - Charge production
  - Slice energy spread
  - Bunch length
  - Beam **asymmetries**, etc.
- > Assist semiconductor photocathode R&D

#### Background:

- + Photocathode R&D usually focuses on "single electron" emission mechanism
- + Operation condition of PITZ for optimized emittance @ transition regime between QE and space charge limited emission regimes
- + Classical electrodynamics seems not sufficient explaining transient PE process
- + Intrinsic emittance modeling not yet thorough

#### Our Challenge: Improved modeling of photoemission process

 $\rightarrow$  At the semiconductor-vacuum interface in the gun how to model quantum mechanics with the presence of strong electromagnetic fields (RF + SPCH = collective effects)



## Space charge dominated PE modeling

#### 1. Driving (UV) laser

- Realistic transverse (Virtual-Cathode-based Core+Halo model\*) distributions
- Realistic temporal distributions
- $\rightarrow$  initializing transient emission process

#### 2. Photocathode

- QE map and QE characterization
- $\rightarrow$  intrinsic emission homogeneity

#### 3. EM fields in close cathode vicinity

- RF, image charge & space charge
- $\rightarrow$  time and space dependent cathode work function modulation

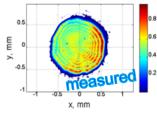
# 4. Quantum mechanics with the presence of strong EM fields at Semiconductor-Vacuum interface

- Surface states
- Band bending
- $\rightarrow$  time and space dependent electron affinity variation
- $\rightarrow$  kinetic energy variation

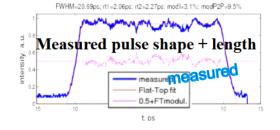
#### 5. Others

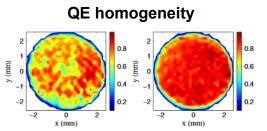
- Temperature
- Surface charge limit\*\*
- Secondary emission, etc.





#### Laser temporal profile

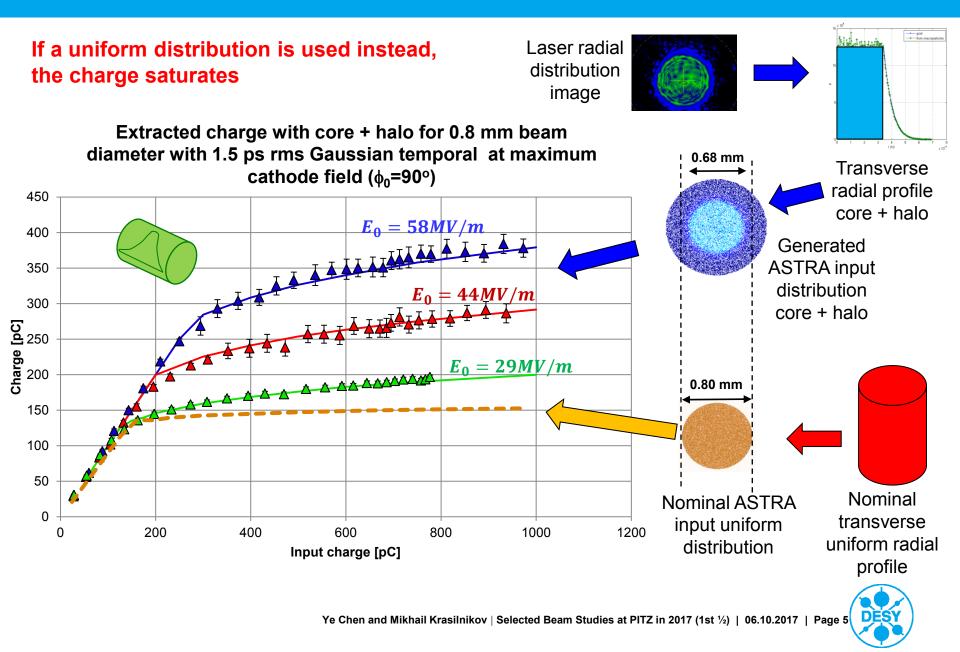




#### \* C. Hernandez-Garcia et al., NIM A 871 (2017) 97–104 \*\*M. Zolotorev, SLAC-PUB-5896 .1992

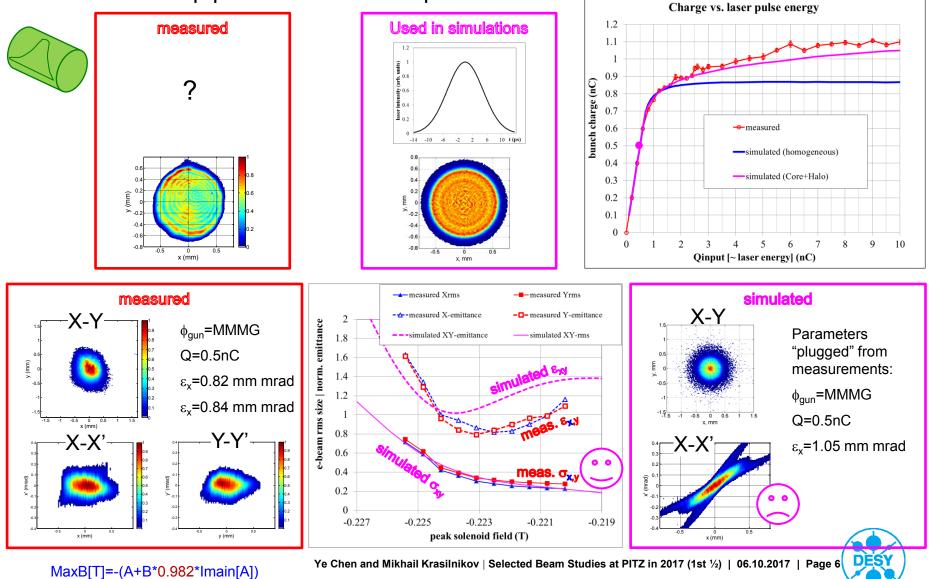


## Status: Core + Halo Model applied to ASTRA simulations



## ASTRA simulations for Gaussian pulses using Core+Halo

#### > BUT for flattop photocathode laser pulses



### Status: ASTRA simulations for 2011 case using Core+Halo

#### > BUT for flattop photocathode laser pulses

y (mm)

-0.5

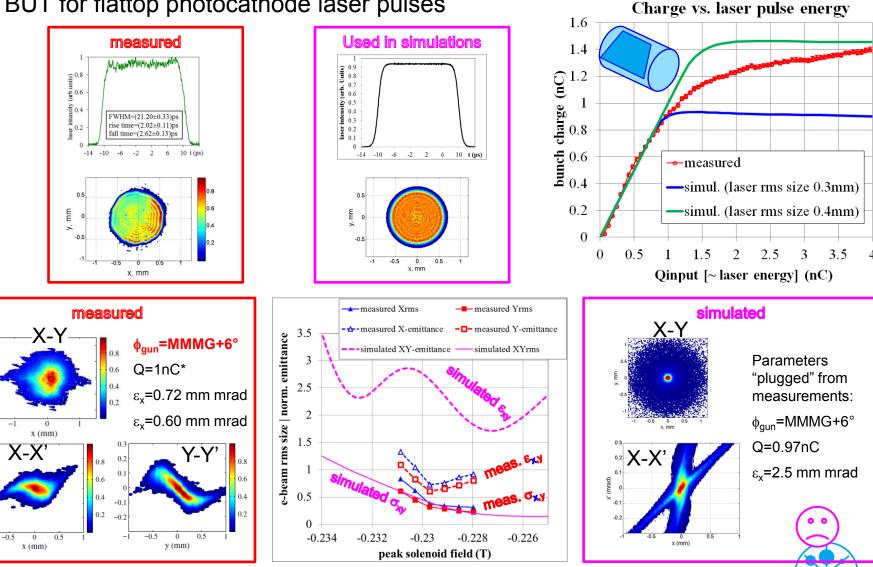
0.3

0.2

0.1

-0.2

-1



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## Status: PE modeling using a 3D full EM Lienard-Wiechert (LW) approach\* \*E. Gjonaj, TEMF, TU Darmstadt

#### LW Approach with 3D emission process

- LW solution for the electromagnetic field of a charged particle in arbitrary motion
- Full particle trajectory stored and used for field computation
- Field-induced work function modification:

$$\Delta \Phi_f(r_\perp, t) = \sqrt{\frac{q^3}{4\pi\varepsilon_0}} \left[ E_{rf}\left(r_\perp, t\right) + E_{sc}\left(r_\perp, t\right) \right]$$

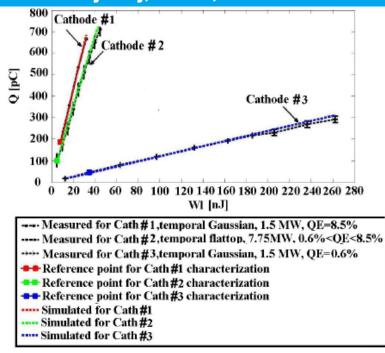
Charge production per simulation time step:

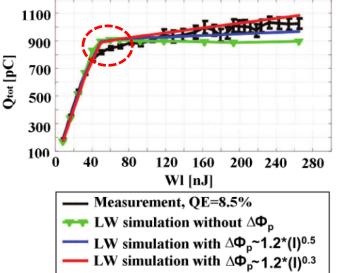
$$dQ\left(\mathbf{r}_{\perp},t\right) = \Delta t \iint_{S} q \frac{P_{l}\left(\mathbf{r}_{\perp},t\right)}{h\nu} QE\left(\mathbf{r}_{\perp},t\right) dS$$
$$QE = \frac{(1-R_{w})\sqrt{1+\frac{hv-\Phi_{w}}{E_{a}}}}{2(p_{0}+1)(1+\frac{E_{a}}{hv-\Phi_{w}})^{2}} \quad \text{K. Jensen, 2007}$$

#### Status

- Dynamic generation of emitted particle distribution at cathode according to time-dependent emission models, taking into account full electromagnetic fields (RF + space-charge) during emission
- Charge production in **QE limited regime** agrees with measurements
- In space charge dominated regime, remaining deviations w.r.t. simulations probably due to:

 ✓ Ideal beam distributions initially plugged in the simulations or/and time dependent work function variation resulting from quantum mechanics





## Further PE modeling: band bending $\rightarrow$ space charge layer

#### Surface states

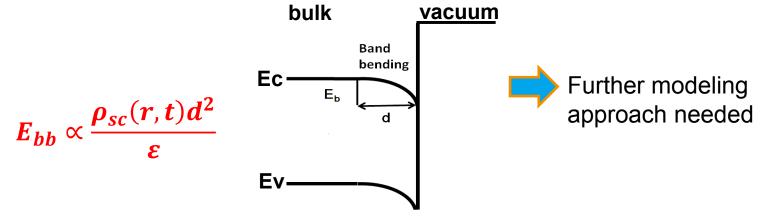
- Due to lattice translational symmetry broken @cathode surface
- Surface band lying within bandgap of the bulk (fewer bonds)
- Possessing charging character

#### Surface states → band bending

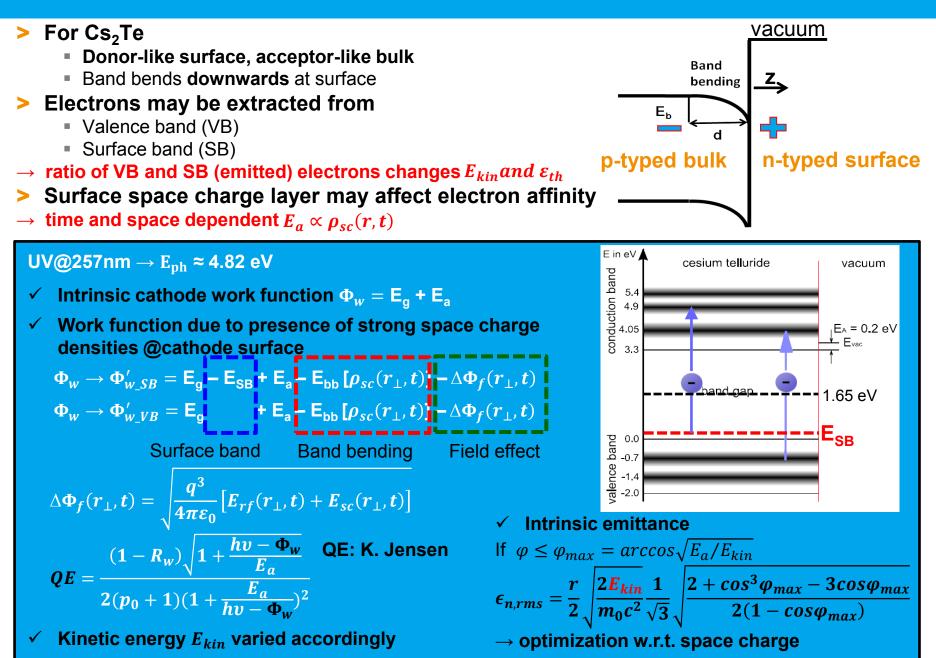
- Charge carriers falling into surface states → "surface charged"
- Matching fermi level at bulk and surface → band bent
- Band bending → **space charge layer formed** (from surface into the bulk)

#### Characteristics

- Band bends quadratically
- Local curvature proportional to local space charge density
- Bending amount and width depending also on material properties



## PE modeling: interpretation of surface space charge layer



## Updates on beam asymmetry studies (RF coupler kick simulations & Gun quadrupole for compensating beam asymmetries)

+ Igor Isaev



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## **Motivation of beam asymmetry studies**

0.8

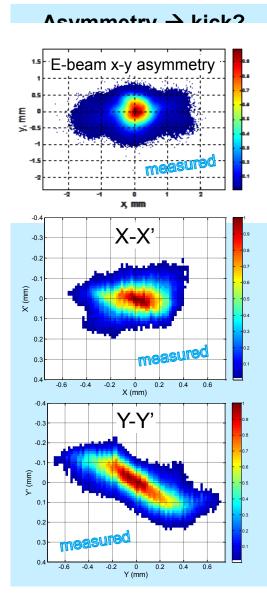
0.7

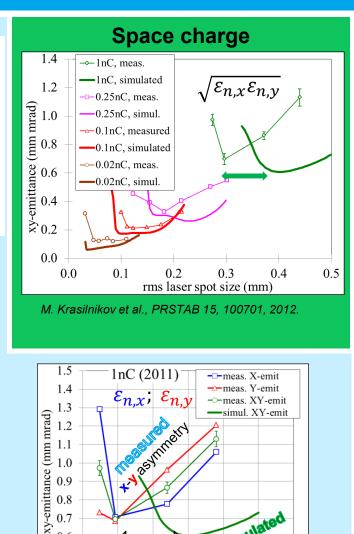
0.6

0.5

0.25

0.3





#### Possible sources of the beam asymmetry:

- Vacuum mirror
- Stray magnetic fields
- Related to the laser polarization
- Particular cathode
- ...
- RF coupler field asymmetry
- · Solenoid imperfections (anomalous quadrupole fields)

#### **Ongoing activities**

- $\rightarrow$  coupler kick simulations
- $\rightarrow$  solenoid field simulations
- $\rightarrow$  simulations with rotational quads model for fitting measurements
- $\rightarrow$  gun quadrupole designs and simulations
- $\rightarrow$  gun quads compensation



0.55

simulated

0.5

0.4

rms laser spot size (mm)

0.45

0.35

# Updates on coupler RF kick studies (no solenoids)

#### Kick characterization

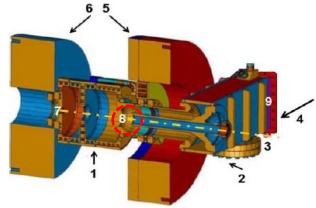
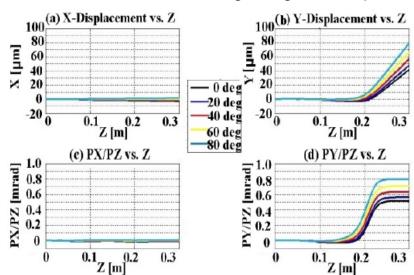


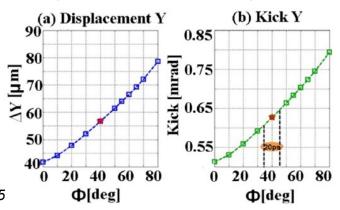
Figure 1: Sketch of the PITZ gun with coaxial RF coupler: 1-gun cavity, 2-door-knob transition, 3-cavity axis, 4-RF feeding direction, 5-main solenoid, 6-bucking solenoid, 7-cathode, 8-end of coaxial line and 9-reference position of WG port for simulations. Note that this sketch is rotated by 90 degrees compared to the computational model used in the follow-up simulations.

- Field calculation done under optimum operation condition of the gun (mini.S11 by adjusting inner conductor length)
- 3D field map used for later particle tracking simulations
- RF dynamics → no solenoids, no space charge Y. Chen et al., FEL2017 proceedings, WEP005



Beam centroid tracking using field map

Vertical displacement at z = 0.3 m and kick strength as a function of the gun phase



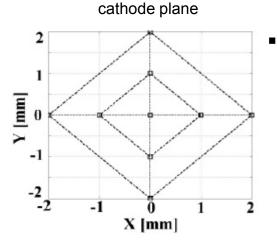


# Updates on coupler RF kick studies (no solenoids)

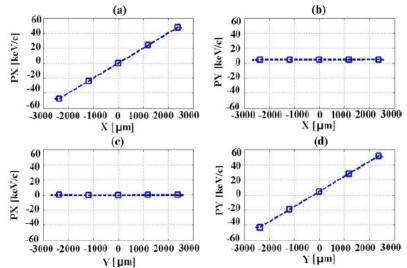
#### Kick quantification

Beam centroid positions on

Particle tracking simulation results for multipole expansion based quantification of the integral kick



Using field map tracking a set of particles on the cathode plane though kick region till doorknob transition region



 Fitting multipole expansion form of the integral kick using simulation results

#### Multipole expansion of the integral kick

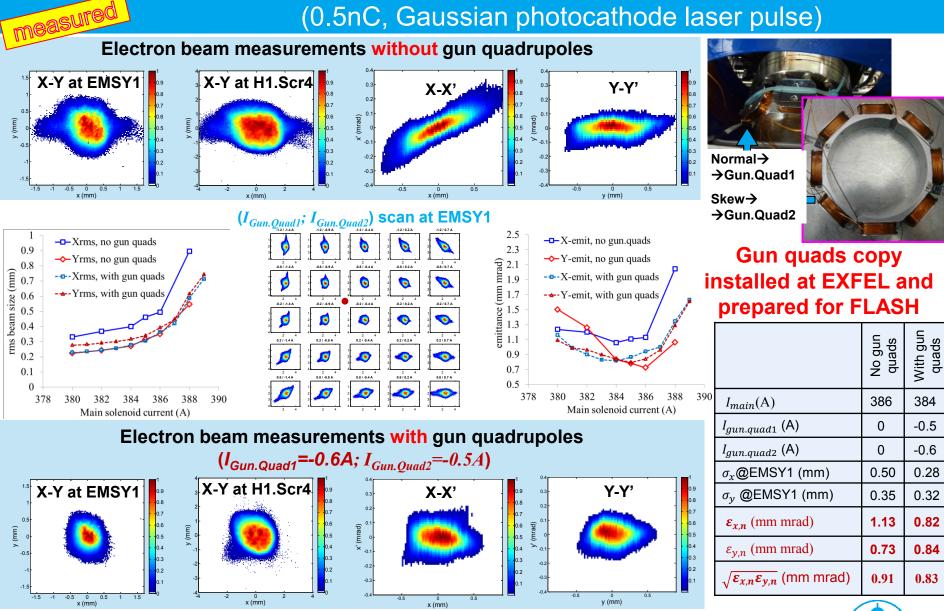
- $P_X = P_{0x} + (K_{RF} + K_N)X + K_SY$  $P_Y = P_{0y} + (K_{RF} K_N)Y + K_SX$
- **X**, **Y**: particle offsets from the axis at the location of the integral kick
- $P_x$ ,  $P_y$ : particle transverse momenta in the horizontal and vertical direction

 $P_{ox}$ ,  $P_{oy}$ : horizontal and vertical dipole kicks  $K_{RF}$ : RF focusing strength of cylindrical symmetric mode  $K_N$  and  $K_s$ : normal and skew quadrupole kick strength

- ✓ Vertical dipole kick~4.576 keV/c, time dependent
- ✓ Quadrupole kick strength estimation
  - Normal quadrupole component ~1.0e-5 keV/c/ $\mu$ m
  - Skew quadrupole component~5.0e-6 keV/c/µm
- ✓ (20-ps) Bunch tail sees higher kick strength than the head by 0.05 mrad @ 6.5MW

## Electron beam X-Y asymmetry compensation with gun quads

(0.5nC, Gaussian photocathode laser pulse)



M. Krasilnikov et al., FEL2017 proceedings, WEP007

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## Summary

- Further photoemission modeling towards quantum mechanics with the presence of strong space charge densities at cathode surface
  - current status
  - further modeling approaches
- Coax coupler RF kick characterized and quantified under optimized operation conditions of the gun
  - Time dependent vertical dipole kick, ~0.65 mrad (MMMG phase, 6.5MW)
  - Small quadrupole kick estimated
- > Beam asymmetry compensation with gun quadrupoles optimization
  - Promising results → "round beam, round emittance"

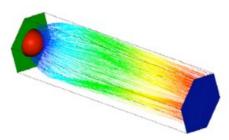
# Thank you very much!



## **Backup: Updates on "Pz modulation" studies**

#### (?)Cathode laser temporal profile

- Long Gaussian (11-11.5ps FWHM, Lyot filter in) →Pz modulation observed
- Short Gaussian (~2ps FWHM, Lyot filter out)  $\rightarrow$  not yet observed
- $\rightarrow$  Lyot filter, the source of modulation?
- (?)Emission mechanism



- Emitted charge  $\rightarrow$  fields on surface that affects subsequent emissions
- $\rightarrow$  "oscillations induced by a sudden influx of charge can persist".

Demonstration for Cu and Cs<sub>3</sub>Sb using MICHELLE

- J.J. Petillo et al., IEE trans. Electron Devices 52, 742 (2005)
- K.L. Jensen et al., J.Vac.Sci. Technol. 26 (2), 831 (2008)

See: M. Krasilnikov, DESY-TEMF-Meeting, 01.2017

